

JCCS Rec'd PCT/PTO 27 MAY 2005

## INFORMATION DISCLOSURE STATEMENT

Applicant : Naotaka KUBOTA, et al.  
App. No : Unknown  
Filed : Herewith  
For : POSITIVE RESIST COMPOSITION  
Examiner : Unknown  
Art Unit : Unknown

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing twelve (12) references to be considered by the Examiner. Also enclosed are seven (7) foreign patent references as listed on the Information Disclosure Statement. Documents JP 2002-16272745A (listing 10), KR 2002-0082781 (listing 11) and JP 2003-243352A (listing 12) are without English abstract. However as indicated in the accompanying Form PCT/ISA/210 and PCT/IPEA/408, all of the listed references were cited in the International Search Report and the written opinion of the International Preliminary Examination in the international phase of the present U.S. national phase application. Although these references already of record during the International Phase of the application, they are submitted in the present Information Disclosure Statement for the convenience of the Examiner and to endure that the references are listed on the cover of any patent issued on the present application. This Information Disclosure Statement is being filed within three months of the filing date, with an RCE or before receipt of a first office action after an RCE and no fee is required.

The Commissioner is hereby authorized to charge any fees which may be required to Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: May 27, 2005

By: 

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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	PCT Application No.	PC 03/015346
	PCT Filing Date	December 1, 2003
	First Named Inventor	Naotaka KUBOTA
	Art Unit	Unknown
(Multiple sheets used when necessary)	Examiner	Unknown
SHEET 1 OF 1	Attorney Docket No.	SHIGA7.020APC

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1.	4,944,837	07/31/1990	Masaru NISHIKAWA, et al.	
	2.	5,326,672	07/05/1994	Toshihiko TANAKA, et al.	
	3.	5,374,502	12/20/1994	Toshihiko TANAKA, et al.	
	4.	2002/0102492 A1	08/01/2002	Takeshi IWAI, et al.	
	5.	2002/0184788 A1	12/12/2002	Nobuyuki KAWAKAMI, et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
	6.	JP 1-220828	09/04/1989	Masaru NISHIKAWA, et al.		abstract
	7.	JP 5-315241	11/26/1993	Toshihiko TANAKA, et al.		abstract
	8.	JP 9-82629	03/28/1997	Yoshio YAMASHITA, et al.		abstract
	9.	JP 2000-338674A	12/08/2000	Kenichiro SATO, et al.		abstract
	10.	JP 2002-162745A	06/07/2002	Takeshi IWAI, et al.		X
	11.	KR 2002-0082781	10/31/2002			X
	12.	JP 2003-243352A	08/29/2003	N. KAWAKAMI, et al.		X

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>1</sup>

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Examiner Signature	Date Considered
<b>*Examiner:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.